

## **TEST CELL FOR SOLID DIELECTRIC MATERIALS**

## LDZ-5/S1



## **Field of application**

The test cell LDZ-5/S1 for solid dielectric materials is designed according to the national and international standards DIN 53483 part 2 and VDE 0303 part 30 and IEC.

The LDZ-5/S1 is applicable in connection with the Dielectric Analyzer DIANA or the DSP-based Dissipation Factor & Capacitance Measuring System LDV-5. It is intended for measurement the capacitance ( $C_x$ ), the loss factor (tan  $\delta$ ) and the relative permittivity ( $\epsilon_r$ ) of solid insulating materials. Due to the arrangement of the electrodes it is additional possible to measure the resistivity of the insulating material and the surface resistance in connection with a suitable measuring instrument, such as the Digital TERA-Ohmmeter DT-08.

The test cell for solid dielectric materials LDZ-5/S1 consists of two parallel plate electrodes. The measuring electrode is shielded by a guard electrode for the elimination of stray capacitances. At the front a gauge is fixed for the measurement of the thickness of the insulating material.

Due to the compact design the test cell can be placed inside the HV test box of the Dielectric Analyzer DIANA.



## **Technical parameters**

Diameter measuring electrode Width guard gap Width guard electrode Diameter high voltage electrode Electrode material	100 mm 1 mm 20 mm 142 mm Stainless steel, polished
Connections	<ul> <li>BNC for the measuring electrode</li> <li>Lab socket for the high voltage electrode</li> <li>Lab socket for the guard electrode</li> </ul>
Maximum test voltage	2 kV AC r.m.s. (depend on the thickness of the test sample)
Dimensions (I x h x w) Weight (total) Weight of the high voltage electrode alone	approx. 170 mm x 135 mm x 210 mm approx. 4.2 kg approx. 2.0 kg
Storage and transport conditions	
Storage temperature	- 15 °C to + 55 °C
Storage humidity	≤ 90 %
Operation conditions	
Operation temperature Operation humidity	+ 5 °C to + 40 °C ≤ 85 %
Protection class	IP 00